		EAST SEARCH 4/15/04	
#_	Hits	Search String Databases	
2 2	2 0		PO; JPO; DERWENT; IBM_TDB
S =	473212		DERWENT
	1329	(integrated or digital) adj circuit\$1) and (HD) near? (description or describe\$1)\ \text{\text{\$1}SDAT: 11S-PGPTR: FPO: JPO: }	PO, JPO, DERWEINT, IBM_TOB
<u></u>	4	>	DERWENT:
67	48	((integrated or digital) adj circuit\$1) and ((HDL near2 (description or describe\$1)) s USPAT; US-PGPUB; EPO; JPO;	PO; JPO; DERWENT; IBM_TDB
L10	7	((integrated or digital) adj circuit\$1) and ((HDL near2 (description or describe\$11)) :USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	PO; JPO; DERWENT; IBM_TDB
L11	26	(((integrated or digital) adj circuit\$1) and (HDL near2 (description or describe\$1))) USPAT, US-PGPUB; E	EPO; JPO; DERWENT; IBM_TDB
L12	7	(((integrated or digital) adj circuit\$1) and (HDL near2 (description or describe\$1))) USPAT; US-PGPUB; EPO; JPO;	PO; JPO; DERWENT; IBM_TDB
L13	28	(((integrated or digital) adj circuit\$1) and ((HDL near2 (description or describe\$1)): USPAT; US-PGPUB; EPO; JPO;	PO; JPO; DERWENT; IBM_TDB
7	78	(((integrated or digital) adj circuit\$1) and ((HDL near2 (description or describe\$1)): USPAT; US-PGPUB; EPO; JPO;	DERWENT; I
L 3	16	((integrated or digital) adj circuit\$1) and ((HDL near2 (description or describe\$1)) : USPAT; US-PGPUB; EPO; JPO; DERWENT; I	PO; JPO; DERWENT; IBM_TDB
4	80	((integrated or digital) adj circuit\$1) and ((HDL near2 (description or describe\$1)) : USPAT; US-PGPUB; EPO; JPO; DERWENT; I	PO; JPO; DERWENT; IBM_TDB
L5	თ	((integrated or digital) adj circuit\$1) and ((HDL near2 (description or describe\$1)) :USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	PO; JPO; DERWENT; IBM_TDB
P-	တ	(((integrated or digital) adj circuit\$1) and (HDL near2 (description or describe\$1))) USPAT; US-PGPUB; EPO;	PO
F 8	9	(((integrated or digital) adj circuit\$1) and (HDL near2 (description or describe\$1))) :USPAT; US-PGPUB; E	EPO; JPO; DERWENT; IBM_TDB
77	45	((integrated or digital) adj circuit\$1) and (debug\$4 with (target near2 (environment USPAT; US-PGPUB; EPO; JPO;	PO; JPO; DERWENT; IBM_TDB
67	7	(integrated or digital) adj circuit\$1) and (debug\$4 with (target near2 environment) USPAT; US-PGPUB; E	EPO; JPO; DERWENT; IBM_TDB
L10	7	USPAT; US-PGPUB;	EPO; JPO; DERWENT; IBM_TDB
L11	_		
	0	(((integrated or digital) adj circuit\$1) and (HDL near2 (description or describe\$1))) :USPAT; US-PGPUB; E	JPO; DERWENT; I
	7		DERWENT;
	7	(((integrated or digital) adj circuit\$1) and (HDL near2 (description or describe\$1))) :USPAT; US-PGPUB; E	EPO; JPO; DERWENT; IBM_TDB
	06	(((integrated or digital) adj circuit\$1) and (HDL near2 (description or describe\$1))) :USPAT; US-PGPUB; EPO; JPO;	
	22	(((integrated or digital) adj circuit\$1) and (HDL near2 (description or describe\$1))) :USPAT; US-PGPUB; E	EPO; JPO; DERWENT; IBM_TDB
	113	(((integrated or digital) adj circuit\$1) and (HDL near2 (description or describe\$1))) :USPAT; US-PGPUB; E	EPO; JPO; DERWENT; IBM_TDB
	4	debug\$4)) and (state! USPAT; US-PGPUB;	EPO; JPO; DERWENT; IBM_TDB
	0	5,937,190.pn. and (control near2 signal)	EPO; JPO; DERWENT; IBM_TDB
	9	and ((HDL near2 (description or describe\$1)) same debug\$4)) and (signal with (HEUSPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	OO; JPO; DERWENT; IBM_TDB
L10	17	((integrated or digital) adj circuit\$1) and ((HDL near2 (description or describe\$1)) : USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	PO; JPO; DERWENT; IBM_TDB
09/724585		John Beardslee et al.	

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4/15/04

Abstract

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Method and arrangement for passing data between a reference chip and an exterr Architecture and methods for a hardware description language source level debug Asynchronous input/output for integrated circuits that latches external asynchronous Architecture and methods for a hardware description language source level analys System for frame-based protocol, graphical capture, synthesis, analysis, and simul Method and apparatus for testing software Dual ROM microprogrammable microprocessor and universal serial bus microcont Apparatus and method for synthesizing integrated circuits using parameterized HD Datapath synthesis method and apparatus utilizing a structured cell library Fabricated integrated circuit debugging method e.g. for application specific integra Fabricated integrated circuits debugging method for electronic system designs, inv Computer system debugging method involves translating debug data received fron Hardware debugging system for debugging electronic system containing electronic
US 6154803 A US 6132109 A US 6041371 A US 5937190 A US 5920711 A US 581059 A US 5841663 A US 5841663 A US 5519627 A US 55196441 A